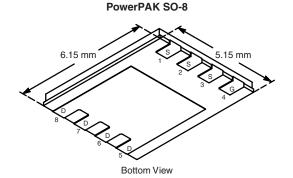




N-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|-----------------------------------|---------------------------------|-----------------------|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) ^a | Q _g (Typ.) | |
| 30 | 0.0031 at V _{GS} = 10 V | 40 | 37 nC | |
| | 0.0036 at V _{GS} = 4.5 V | 40 | 37 110 | |



Ordering Information: Si7664DP-T1-E3 (Lead (Pb)-free)

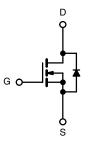
Si7664DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- · Halogen-free available
- TrenchFET[®] Power MOSFET
- PWM Optimized
- New Low Thermal Resistance PowerPAK[®] Package with Low 1.07 mm Profile
- 100 % R_q, Capacitance and UIS Tested

APPLICATIONS

- · Synchronous Low Side
 - Notebook
 - Server
 - Workstation



N-Channel MOSFET

| Parameter | Symbol | Limit | Unit | | |
|-----------------------------------------------------|------------------------|-----------------------------------|---------------------|--------|------|
| Drain-Source Voltage | V _{DS} | 30 | v | | |
| Gate-Source Voltage | | V _{GS} | | | ± 12 |
| | T _C = 25 °C | | 40 | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | I- | 32 | | |
| Continuous Diam Current (1) = 130 °C) | T _A = 25 °C | I _D | 31 ^{b, c} | | |
| | T _A = 70 °C | | 25 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | 70 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | l _a | 40 | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | l _S | 4.9 ^{b, c} | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 40 | \neg | |
| Single Pulse Avalanche Energy | | E _{AS} | 80 | | |
| | T _C = 25 °C | | 83 | | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 53 | w | |
| | T _A = 25 °C | ' D | 5.4 ^{b, c} | VV | |
| | T _A = 70 °C | | 3.4 ^{b, c} | 7 | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 150 | °C | |
| Soldering Recommendations (Peak Temperature | Š | 260 | | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---------------------------------------------|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 10 s | R_{thJA} | 18 | 23 | °C/W | |
| Maximum Junction-to-Case (Drain) | Steady State | R _{thJC} | 1.0 | 1.5 |] | |

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. See Solder Profile (https://www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 65 °C/W.

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| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|-----------------------------------------------|----------------------------------|-------------------------------------------------------------------------------------------------|------|--------|--------|-------------|--|
| Static | , | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | 30 | | | V | |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | J 050 vA | | 35 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | 5.0 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 0.6 | | 1.8 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$ | | | ± 100 | nA | |
| <u> </u> | | V _{DS} = 30 V, V _{GS} = 0 V | 1 | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C | | | μA | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 30 | | | Α | |
| | | V _{GS} = 10 V, I _D = 20 A | | 0.0025 | 0.0031 | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$ | | 0.0029 | 0.0036 | Ω | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 20 A | | 108 | | S | |
| Dynamic ^b | | | | | | l | |
| Input Capacitance | C _{iss} | | | 5180 | 7770 | pF | |
| Output Capacitance | C _{oss} | V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz | | 880 | 1320 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 305 | 458 | | |
| T. 10 1 0 | | V _{DS} = 15 V, V _{GS} = 10 V, I _D = 20 A | | 85 | 125 | 1 | |
| Total Gate Charge | Q_g | | | 38 | 55 | nC | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$ | | 10.5 | | | |
| Gate-Drain Charge | Q_{gd} | | | 5.5 | | | |
| Gate Resistance | R_g | f = 1 MHz | | 0.95 | 1.5 | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 14 | 21 | | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω | | 100 | 150 | | |
| Turn-Off Delay Time | t _{d(off)} | | | 45 | 70 | | |
| Fall Time | t _f | | | 8 | 15 | | |
| Turn-On Delay Time | t _{d(on)} | | | 28 | 45 | ns | |
| Rise Time | t _r | $V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$ | | 103 | 155 | - - - | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 41 | 65 | | |
| Fall Time | t _f | | | 9 | 15 | | |
| Drain-Source Body Diode Characteris | stics | | | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 40 | А | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 70 | | |
| Body Diode Voltage | V_{SD} | I _S = 5 A | | 0.73 | 1.1 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 35 | 55 | ns | |
| Body Diode Reverse Recovery Charge C | | I _F = 10 A, di/dt = 100 A/μs, T _{.I} = 25 °C | | 35 | 55 | nC | |
| Reverse Recovery Fall Time | t _a | $I_F = 10 \text{ A, di/dt} = 100 \text{ A/µs, } I_J = 25 \text{ °C}$ | | 18 | | ns | |
| Reverse Recovery Rise Time | t _b | | | 17 | | | |

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

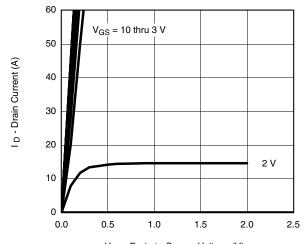
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.



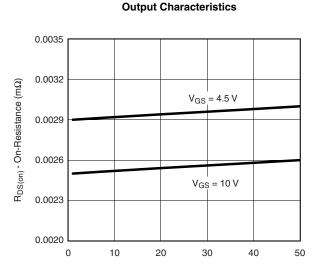




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

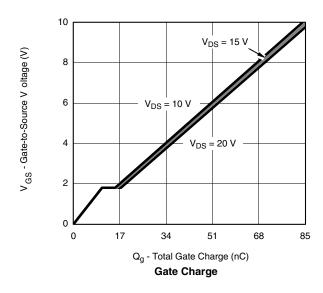


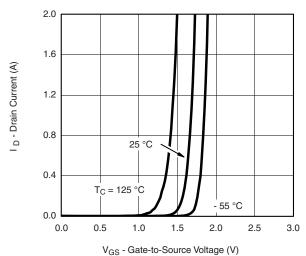
V_{DS} - Drain-to-Source Voltage (V)



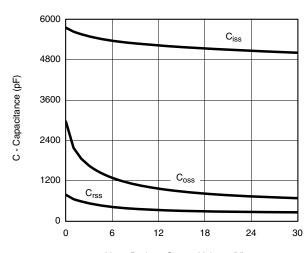
I_D - Drain Current (A)

On-Resistance vs. Drain Current and Gate Voltage

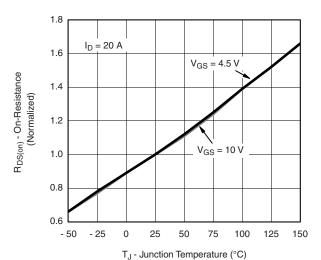




Transfer Characteristics



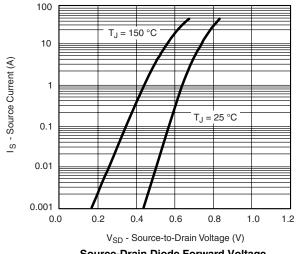
V_{DS} - Drain-to-Source Voltage (V) **Capacitance**



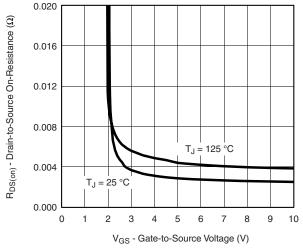
On-Resistance vs. Junction Temperature

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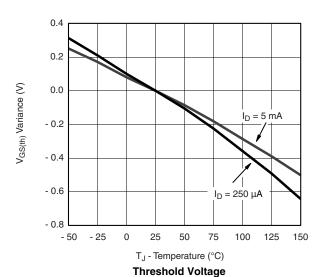
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







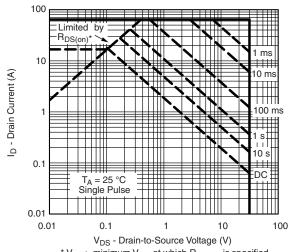
On-Resistance vs. Gate-to-Source Voltage



160 120 Power (W) 80 40 0 0.01 0.1 0.001 10 Time (s)

200

Single Pulse Power, Junction-to-Ambient

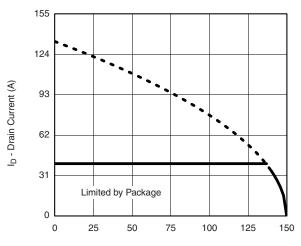


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

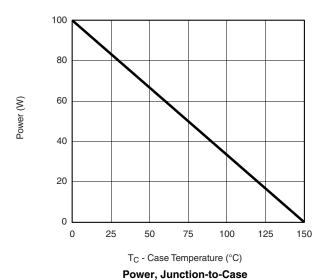


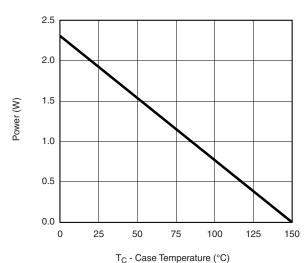
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





Power, Junction-to-Ambient

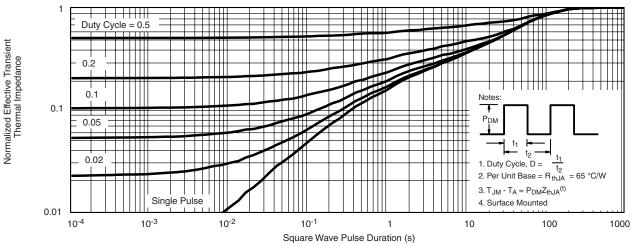
Document Number: 73566 S-80438-Rev. B, 03-Mar-08

^{*} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

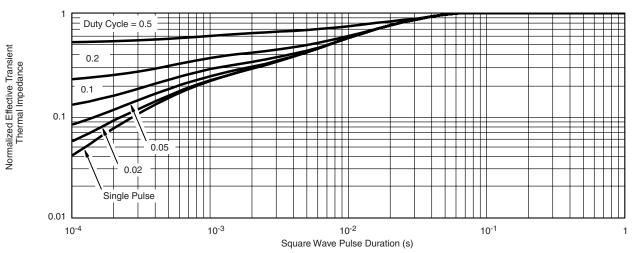
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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